

United States Patent [19]

Beidler et al.

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[45] ** Aug. 16, 1977

[54] REAGENT STRIP REFLECTANCE
PHOTOMETER

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[**] Term: 14 Years

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[52] U.S. Cl. D24/17

[58] Field of Search D32/2 C; 23/230, 292;
356/201, 234, 213, 205; D83/1 F

[56]

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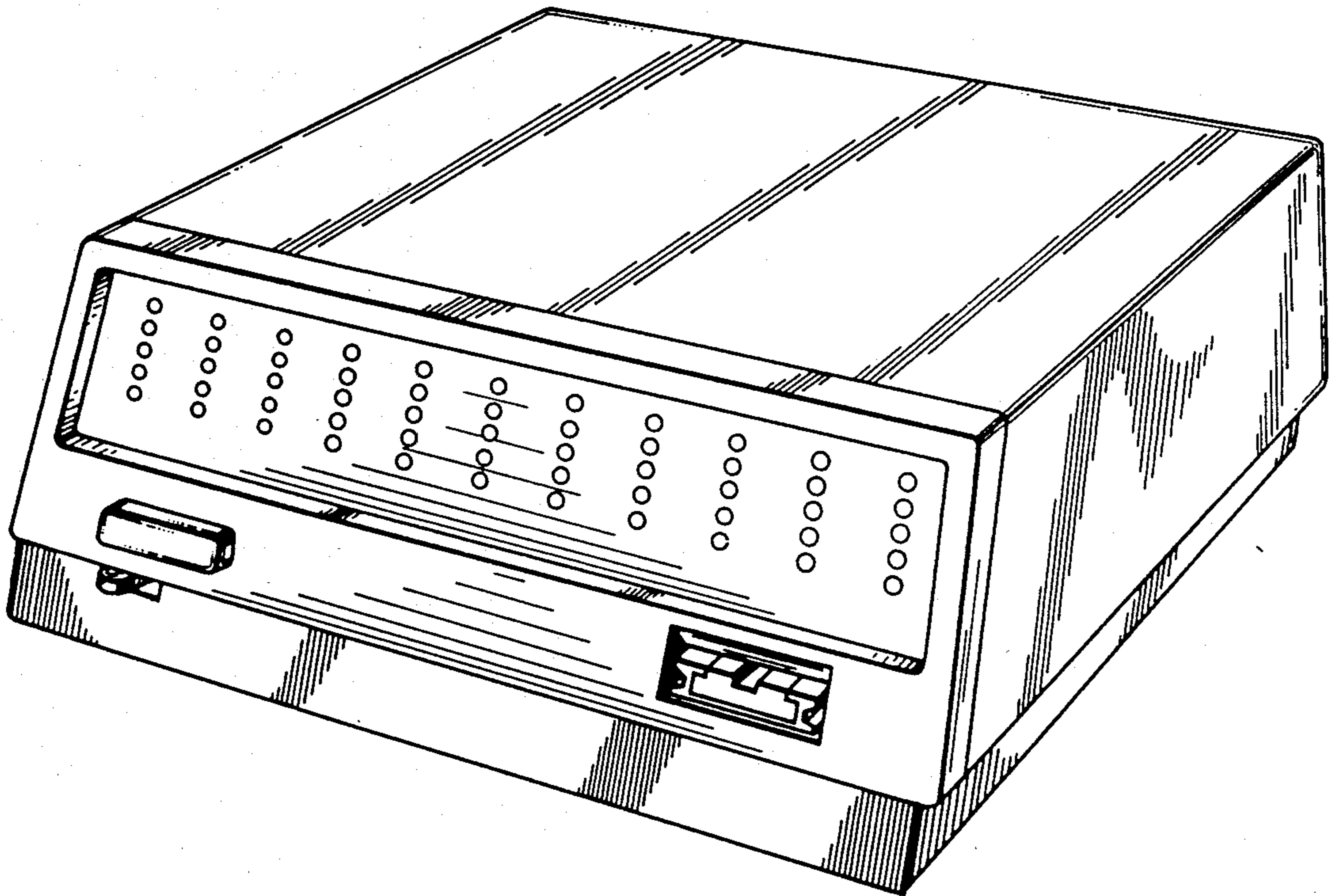
[57]

CLAIM

The ornamental design for the reagent strip reflectance photometer, substantially as shown and described.

DESCRIPTION

The single FIGURE is a front perspective view of a reagent strip reflectance photometer showing the new design. The undisclosed rear, side and bottom of the reagent strip reflectance photometer are plain and unornamented.



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